

Features

- 3rd generation SiC MOSFET technology
- Optimized package with separate driver source pin
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q_n)
- · Halogen free, RoHS compliant

Benefits

- · Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

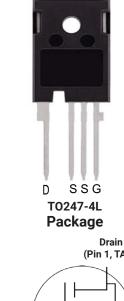
Applications

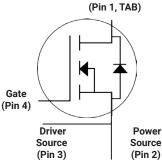
- Renewable energy
- EV battery chargers
- High voltage DC/DC converters
- Switch Mode Power Supplies





Ordering Part Number	Package	Marking	
HC2M0040120K	T0247-4L	HC2M0040120K	





Maximum Ratings ($T_c = 25 \, ^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions
V_{DSmax}	Drain - Source Voltage	1200	٧	V _{GS} = 0 V, I _D = 100 μA
V_{GSmax}	Gate - Source Voltage (dynamic)	-10/+25	٧	AC (f >1 Hz)
V_{GSop}	Gate - Source Voltage (static)	-5/+20	٧	Static
	Continuous Drain Current	78	^	V _{GS} = 15 V, T _C = 25°C
I _D Continuous Drain	Continuous Diain Current	57	A	V _{GS} = 15 V, T _C = 100°C
I _{D(pulse)}	Pulsed Drain Current	TBD	Α	Pulse width t _P limited by T _{jmax}
P _D	Power Dissipation	405	W	$T_{c} = 25^{\circ}C, T_{J} = 175^{\circ}C$
T _J , T _{stg}	Operating Junction and Storage Temperature	-40 to +175	°C	
T _L	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s



Electrical Characteristics (T_c = 25°C unless otherwise specified)

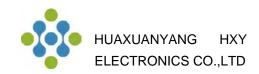
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note
V _{(BR)DSS}	Drain-Source Breakdown Voltage	1200			٧	V _{GS} = 0 V, I _D = 100 μA	
	V 0 . T . I IIV !:	2.0	2.5	4.0	٧	V _{DS} = V _{GS} , I _D = 10 mA	Fig. 11
$V_{GS(th)}$	Gate Threshold Voltage		1.5		٧	V _{DS} = V _{GS} , I _D = 10 mA, T _J = 175°C	
I _{DSS}	Zero Gate Voltage Drain Current		1	50	μA	V _{DS} = 1200 V, V _{GS} = 0 V	
I _{GSS}	Gate-Source Leakage Current		10	200	nA	V _{GS} = 20 V, V _{DS} = 0 V	
		-200	-10		nA	V _{GS} = -10 V, V _{DS} = 0 V	
D	Drain-Source On-State Resistance		40	50	mΩ	V _{GS} = 20 V, I _D = 40 A	Fig. 4,
$R_{DS(on)}$	Dialif-Source Off-State Resistance		59		111122	$V_{GS} = 20 \text{ V}, I_D = 40 \text{ A}, T_J = 175^{\circ}\text{C}$	5, 6
g_{fs}	Transconductance		10.4		S	V _{DS} = 20 V, I _{DS} = 40 A	Fig. 7
Yts	Transconductance		7.7			V_{DS} = 20 V, I_{DS} = 40 A, T_{J} = 175°C	
C_{iss}	Input Capacitance		2101				Fig. 17, 18
Coss	Output Capacitance		161		pF	V _{GS} = 0 V, V _{DS} = 1000 V I f = 100 kHz	
C _{rss}	Reverse Transfer Capacitance		14			Vac = 25 mV	
E _{oss}	C _{oss} Stored Energy		90		μJ		Fig. 16
Eon	Turn-On Switching Energy (SiC Diode FWD)		1100		V _{DS} = 800 V, V _{GS} = -5 V/+20 V, I _D = 40 A		, Fig. 26
E _{OFF}	Turn Off Switching Energy (SiC Diode FWD)		900		μJ	$R_{G(ext)} = 2.5\Omega$, L= 100 μ H, Tj = 175°C	Fig. 26
t _{d(on)}	Turn-On Delay Time		22				
t _r	Rise Time		49		Ì	$V_{DD} = 800 \text{ V}, V_{GS} = -5 \text{ V}/20 \text{ V}$	Fig. 27
t _{d(off)}	Turn-Off Delay Time		71		ns	$R_{G(ext)} = 2.5 \Omega$, $I_D = 40 A$ Timing relative to V_{DS}	
t _f	Fall Time		23		ĺ	Jg relative to 1 _{DS}	
R _{G(int)}	Internal Gate Resistance	İ	1.7	1	Ω	f = 1 MHz, V _{AC} = 25 mV	
Q_{gs}	Gate to Source Charge		33			V _{DS} = 800 V, V _{GS} = -5 V/20 V	
Q_{gd}	Gate to Drain Charge		51		nC	I _D = 40 A	Fig. 12
Qg	Total Gate Charge		131				

Reverse Diode Characteristics (T_c = 25°C unless otherwise specified)

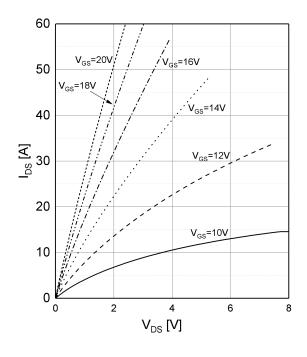
Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
V	V _{SD} Diode Forward Voltage	4.1		V	V _{GS} = -5 V, I _{SD} = 20 A, T _J = 25 °C	Fig. 8,
VSD		3.5		V	V _{GS} = -5 V, I _{SD} = 20 A, T _J = 175 °C	9,10
Is	Continuous Diode Forward Current		83	Α	$V_{GS} = -4 \text{ V, } T_{C} = 25^{\circ}\text{C}$	Note 1
I _{S, pulse}	Diode pulse Current		TBD	Α	V_{GS} = -4 V, pulse width t_P limited by T_{jmax}	Note 1
t _{rr}	Reverse Recover time	56		ns		
Q _{rr}	Reverse Recovery Charge	508		nC	V _{GS} = -5 V, I _{SD} = 40 A, V _R = 800 V dif/dt = 2250 A/μs, T _J = 175 °C	Note 1
I _{rrm}	Peak Reverse Recovery Current	18		Α		

Thermal Characteristics

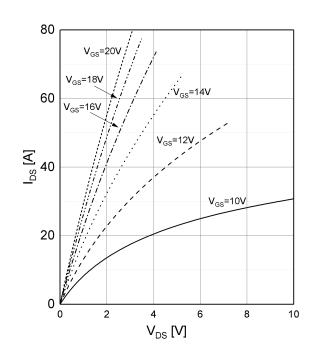
Symbol	Parameter	Тур.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	0.25			F: 01
$R_{\theta JA}$	Thermal Resistance From Junction to Ambient	40	°C/W		Fig. 21



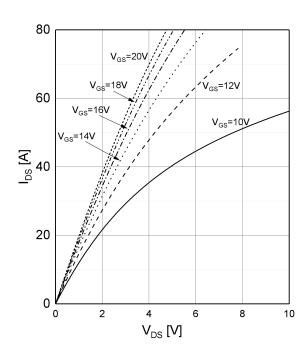
Output characteristics $I_{DS}=f(V_{DS})$, $T_{J}=-55$ °C



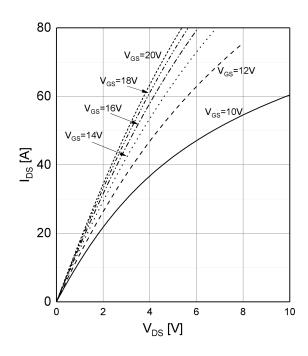
Output characteristics $I_{DS}=f(V_{DS}), T_J=25$ °C



Output characteristics $I_{DS}=f(V_{DS})$, $T_J=150$ °C

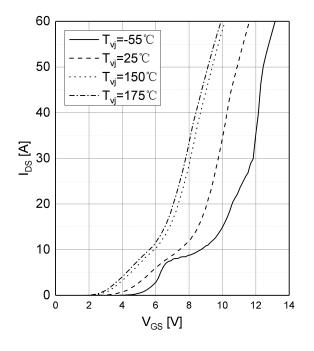


Output characteristics I_{DS}=f(V_{DS}), T_J=175°C

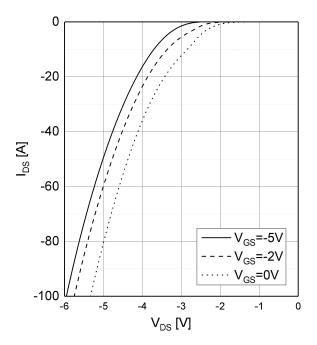




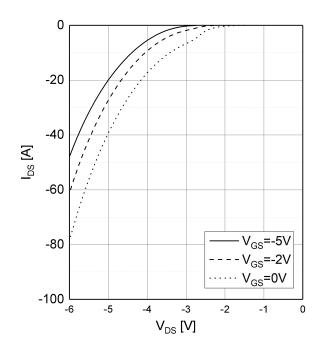
Transfer Characteristics I_{DS} =f(V_{GS}), V_{DS} =20V



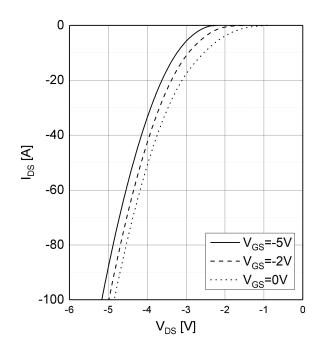
Body Diode Characteristics $I_{DS} = f(V_{DS}), T_J = 25^{\circ}C$



Body Diode Characteristics $I_{DS} = f(V_{DS})$, $T_J = -55$ °C

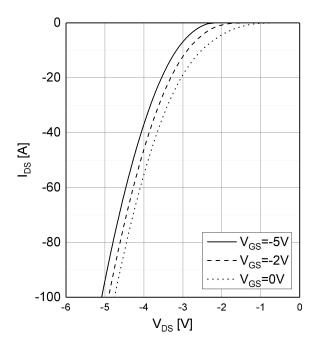


Body Diode Characteristics I_{DS} =f(V_{DS}), T_J=150°C

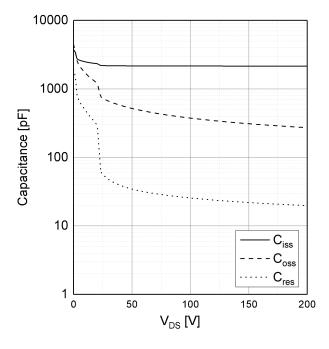




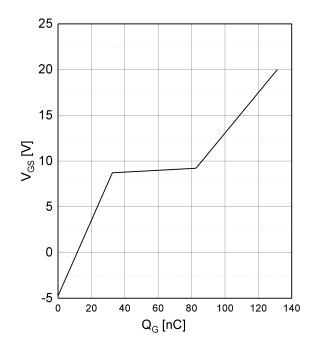
Body Diode Characteristics $I_{DS} = f(V_{DS}), T_J = 175$ °C



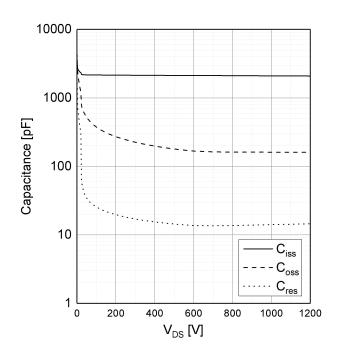
Capacitances vs Drain-Source Voltage (0-200V) $C=f(V_{DS})$, $T_{J}=25$ °C, $V_{AC}=25$ mV, f=100KHz



Gate Charge Characteristics V_{GS} =f(Q_G), I_{DS} =40A, V_{DS} =800V, T_J =25 $^{\circ}$ C

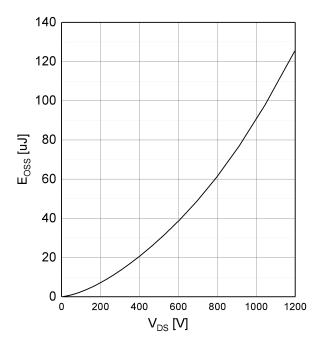


Capacitances vs Drain-Source Voltage (0-1200V) $C=f(V_{DS})$, $T_j=25^{\circ}C$, $V_{AC}=25$ mV, f=100KHz

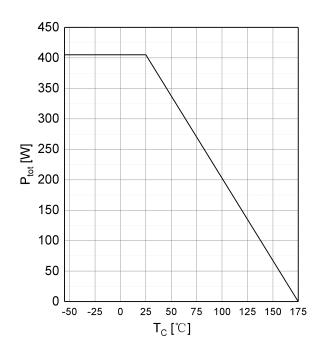




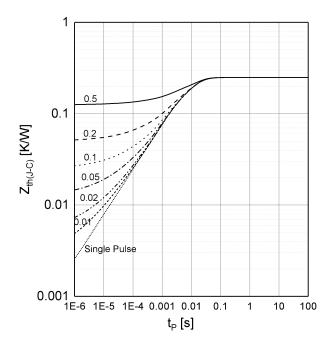
Output Capacitor Stored Energy E_{OSS} =f(V_{DS}), T_J=25°C



 $\begin{aligned} & \text{Maximum Power Dissipation Derating} \\ & P_{tot} = & f(T_C), T_J \leq & 175^{\circ}C \end{aligned}$



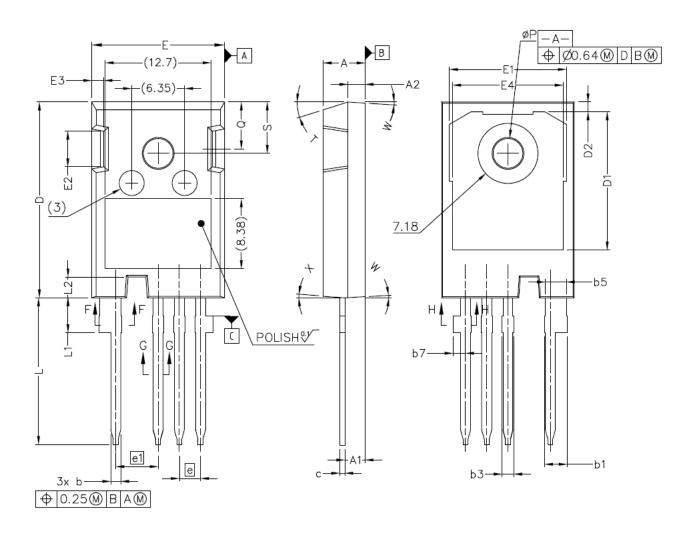
Transient Thermal Impedance (Junction to Case) $Z_{th(J-C)}=f(t)$, $T_C=25$ °C

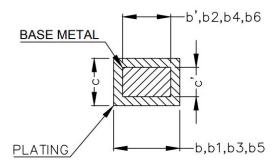




Package Dimensions

Package T0247-4L





SECTION "F-F", "G-G" AND "H-H" SCALE: NONE



Package Dimensions

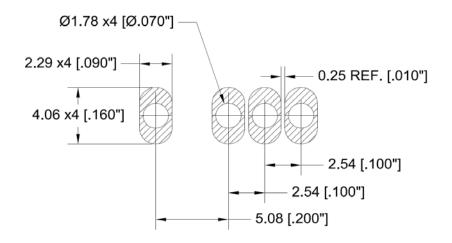
Package TO247-4L

NOTE;

- 1. ALL METAL SURFACES: TIN PLATED, EXCEPT AREA OF CUT
- 2. DIMENSIONING & TOLERANCEING CONFIRM TO ASME Y14.5M-1994.
- 3. ALL DIMENSIONS ARE IN MILLIMETERS. ANGLES ARE IN DEGREES.
- 4. 'N' IS THE NUMBER OF TERMINAL POSITIONS

SYM	MILLIMETERS				
31101	MIN	MAX			
Α	4.83	5.21			
A1	2.29	2.54			
A2	1.91	2.16			
b`	1.07	1.28			
b	1.07	1.33			
b1	2.39	2.94			
b2	2.39	2.84			
b3	1.07	1.60			
b4	1.07	1.50			
b5	2.39	2.69			
b6	2.39	2.64			
b7	1.30	1.70			
c`	0.55	0.65			
С	0.55	0.68			
D	23.30	23.60			
D1	16.25	17.65			
D2	0.95	1.25			
E	15.75	16.13			

SYM	MILLIMETERS				
31101	MIN	MAX			
E1	13.10	14.15			
E2	3.68	5.10			
E3	1.00	1.90			
E4	12.38	13.43			
е	2.54 BSC				
e1	5.08 BSC				
Ν*	4				
L	17.31	17.82			
L1	3.97	4.37			
L2	2.35	2.65			
ØΡ	3.51	3.65			
Q	5.49	6.00			
S	6.04	6.30			
Т	17.5° REF.				
W	3.5° REF.				
Χ	4° REF.				





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TK16J60W,S1VQ(O 2SK2614(TE16L1,Q) DMN1017UCP3-7 DMN1053UCP4-7 SQJ469EP-T1-GE3 NTE2384 DMC2700UDMQ-7
DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B DMN1006UCA6-7 DMN16M9UCA6-7
STF5N65M6 IRF40H233XTMA1 STU5N65M6 DMN6022SSD-13 DMN13M9UCA6-7 DMTH10H4M6SPS-13 DMN2990UFB-7B
IPB80P04P405ATMA2 2N7002W-G MCAC30N06Y-TP MCQ7328-TP BXP7N65D BXP4N65F AOL1454G WMJ80N60C4 BXP2N20L
BXP2N65D BXT1150N10J BXT1700P06M TSM60NB380CP ROG RQ7L055BGTCR DMNH15H110SK3-13 SLF10N65ABV2
BSO203SP BSO211P IPA60R230P6 IPA60R460CE